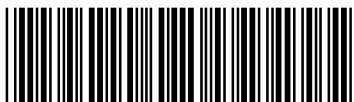


**Search Notes****Application/Control No.**

10/543,118

**Examiner**

Hanh V. Tran

**Applicant(s)/Patent under Reexamination**

BAUER ET AL.

**Art Unit**

3637

**SEARCHED**

Class	Subclass	Date	Examiner
312	405 405.1	9/29/2007	HVT
	401 406		
	116 138.1		
312	321.5		
62	125 126	9/29/2007	HVT
All	Updated	3/19/2008	HVT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search using various key words	9/29/2007	HVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner